

500V N-CHANNEL ENHANCEMENT MODE MOSFET

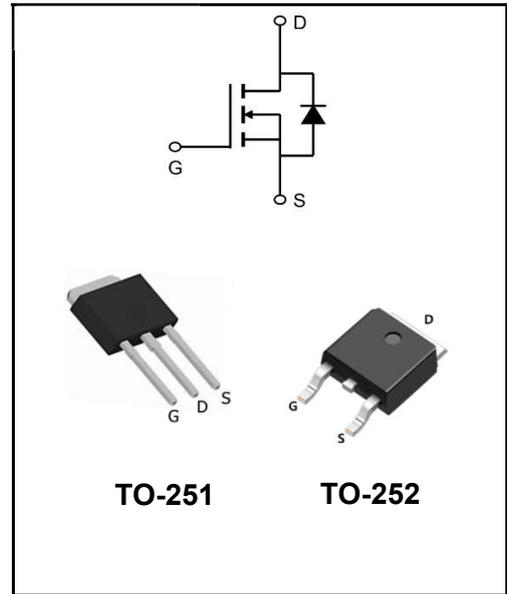
MAIN CHARACTERISTICS

I_D	5A
V_{DSS}	500V
$R_{DS(on)-typ}(@V_{GS}=10V)$	< 1.6Ω (Type: 1.35Ω)



Application

- ◆ Switch Mode Power Supply (SMPS)
- ◆ Uninterruptible Power Supply (UPS)
- ◆ Power Factor Correction (PFC)



Product Specification Classification

Part Number	Package	Marking	Pack
YFW5N50AD	TO-252	YFW 5N50AD XXXXX	2500PCS/Tape
YFW5N50AMJ	TO-251	YFW 5N50AMJ XXXXX	4000PCS/Tape

Maximum Ratings at T_c=25°C unless otherwise specified

Characteristics	Symbols	Value	Units
Drain-Source Voltage	V_{DS}	500	V
Gate - Source Voltage	V_{GS}	±30	V
Continuous Drain Current T _c =25°C	I_D	5	A
Continuous Drain Current T _c =100°C	I_D	3.4	A
Pulsed Drain Current ^{Note1}	I_{DM}	20	A
Single Pulse Avalanche Energy ^{Note2}	E_{AS}	90	mJ
Power Dissipation T _c =25°C	P_D	45	W
Thermal Resistance, Junction-case	$R_{θJC}$	2.8	°C/W
Thermal Resistance, Junction ambient	$R_{θJA}$	60	°C/W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to +150	°C

Maximum Ratings at Tc=25°C unless otherwise specified

Characteristics	Test Condition	Symbols	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	V(BR)DSS	500	-	-	V
Zero Gate Voltage Drain Current	$V_{DS}=500V, V_{GS}=0V, T_J=25^\circ C$	I_{DSS}	-	-	1	μA
Gate to Body Leakage Current	$V_{GS}=\pm 30V$	I_{GSS}	-	-	±100	nA
Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	V_{GS(th)}	2	3	4	V
Static Drain-Source On-Resistance (Note3)	$V_{GS}=10V, I_D=2.5A$	R_{DS(ON)}	-	1.35	1.6	Ω
Input Capacitance	$V_{DS}=25V$ $V_{GS}=0V$ $f=1MHz$	C_{iss}	-	462	-	pF
Output Capacitance		C_{oss}	-	54.2	-	
Reverse Transfer Capacitance		C_{rss}	-	8.8	-	
Total Gate Charge	$V_{DD}=400V$ $I_D=5A$ $V_{GS}=10V$	Q_g	-	13.5	-	nC
Gate-Source Charge		Q_{gs}	-	2	-	
Gate-Drain("Miller") Charge		Q_{gd}	-	6	-	
Turn-on delay time	$V_{DD}=250V$ $I_D=5A$ $R_G=25\Omega$	t_{d(on)}	-	10	-	ns
Turn-on Rise Time		T_r	-	25	-	
Turn-Off Delay Time		t_{d(OFF)}	-	40	-	
Turn-on Fall Time		t_f	-	52	-	
Maximum Continuous Drain to Source Diode Forward Current		I_S	-	-	5	A
Maximum Pulsed Drain to Source Diode Forward Current		I_{SM}	-	-	20	A
Drain to Source Diode Forward Voltage	$V_{GS}=0V, I_{SD}=5A, T_J=25^\circ C$	V_{SD}	-	-	1.4	V
Reverse Recovery Time	$V_{GS}=0V, I_S=5A, di_{SD}/dt=100A/\mu s$	t_{rr}	-	220	-	ns
Reverse Recovery Charge		Q_{rr}	-	3	-	nC

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. IAS = 3A, VDD = 50V, RG = 25Ω, Starting TJ = 25°C
3. Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 1%

Ratings and Characteristic Curves

Figure 1: Output Characteristics

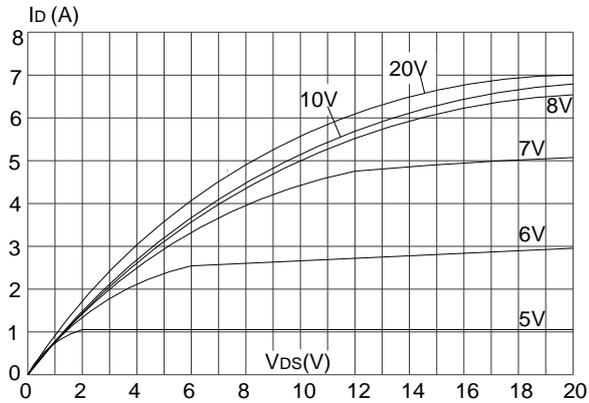


Figure 2: Typical Transfer Characteristics

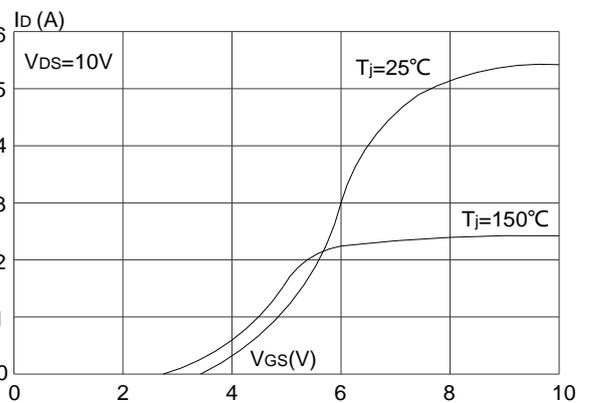


Figure 3: On-resistance vs. Drain Current

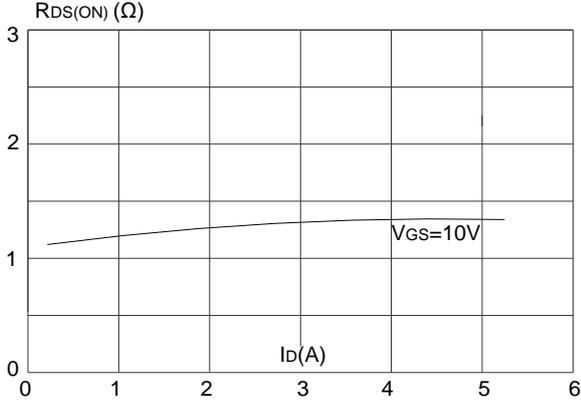


Figure 4: Body Diode Characteristics

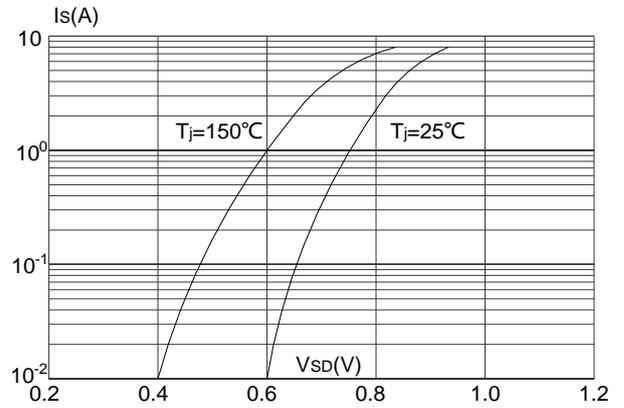


Figure 5: Gate Charge Characteristics

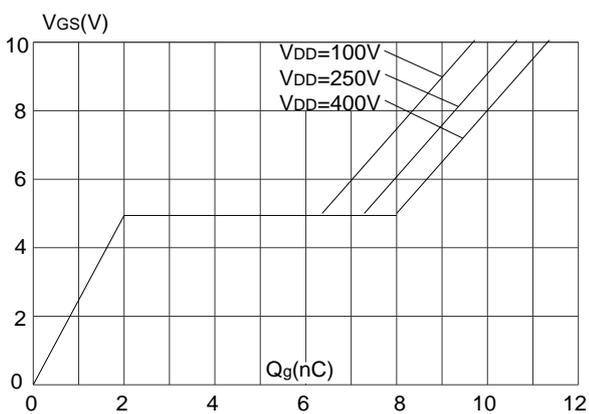
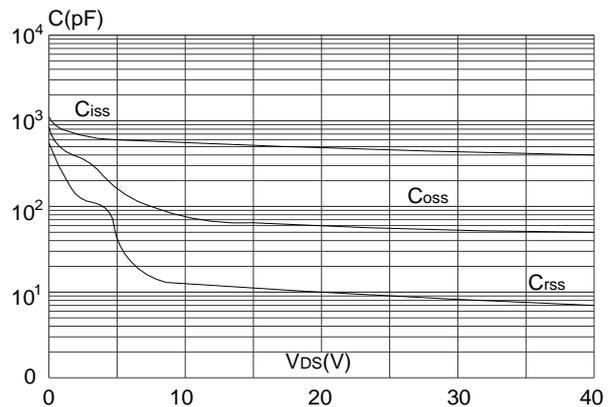


Figure 6: Capacitance Characteristics



Ratings and Characteristic Curves

Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

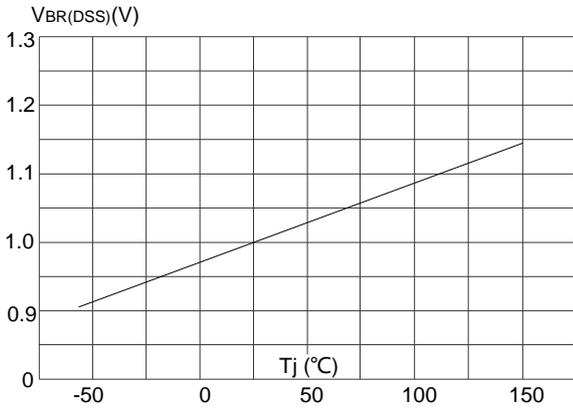


Figure 8: Normalized on Resistance vs. Junction Temperature

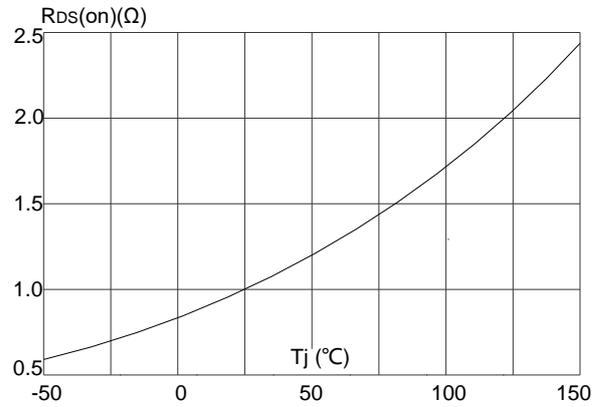


Figure 9: Maximum Safe Operating Area

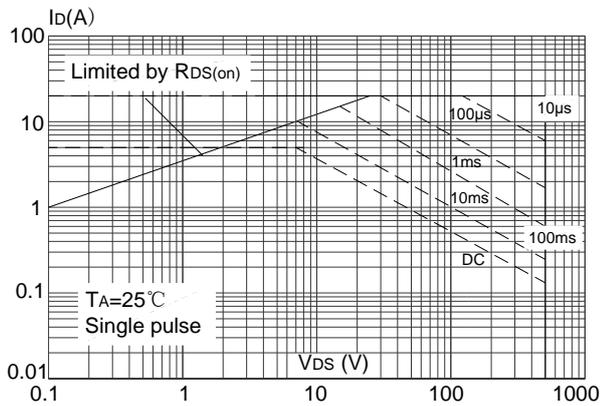


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

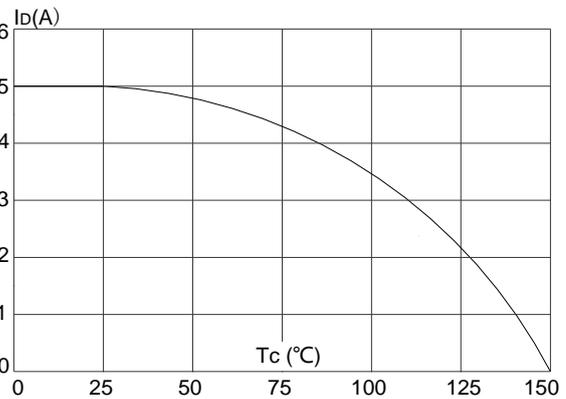


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case (TO-220C, TO-251, TO-251S, TO-252)

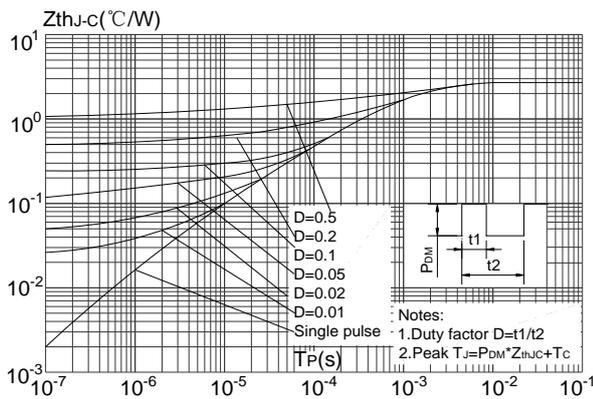
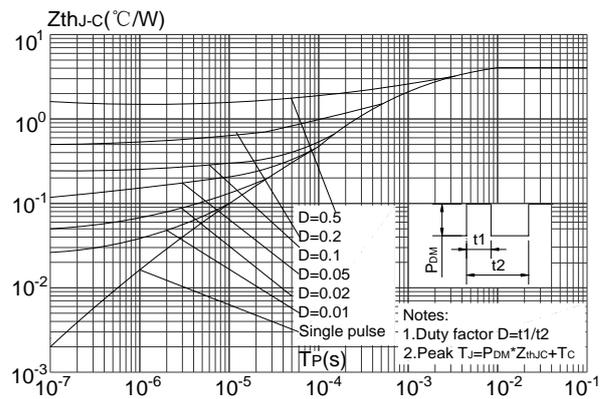


Figure.12: Maximum Effective Transient Thermal Impedance, Junction-to-Case (TO-220F)



Ratings and Characteristic Curves

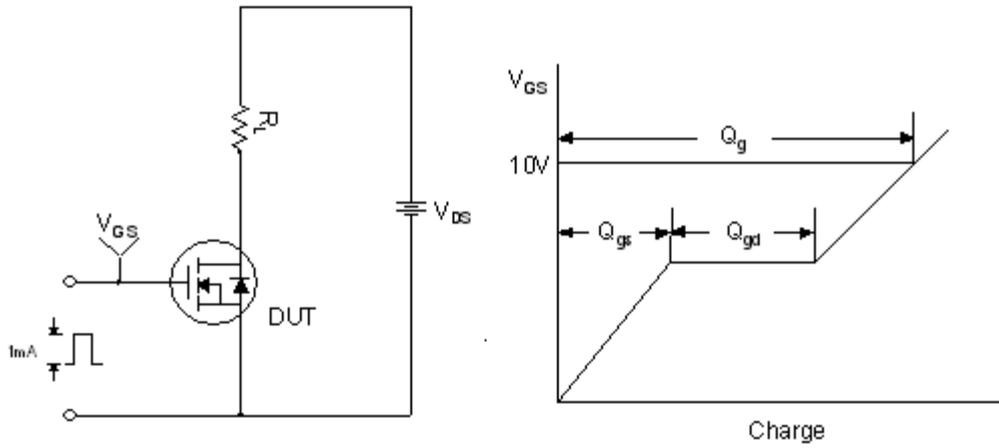


Figure 13. Gate Charge Test Circuit & Waveform

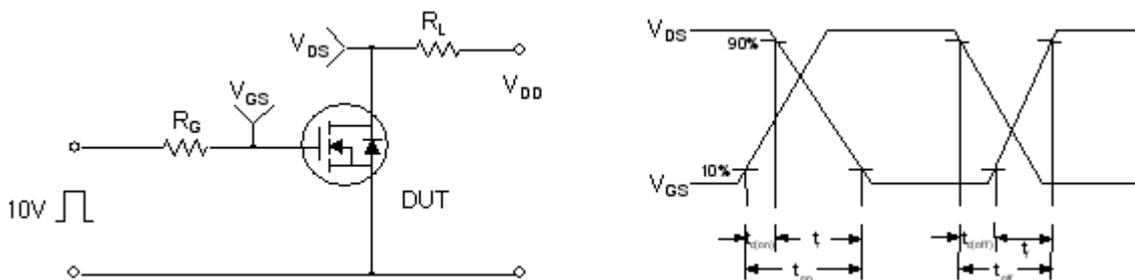


Figure 14. Resistive Switching Test Circuit & Waveforms

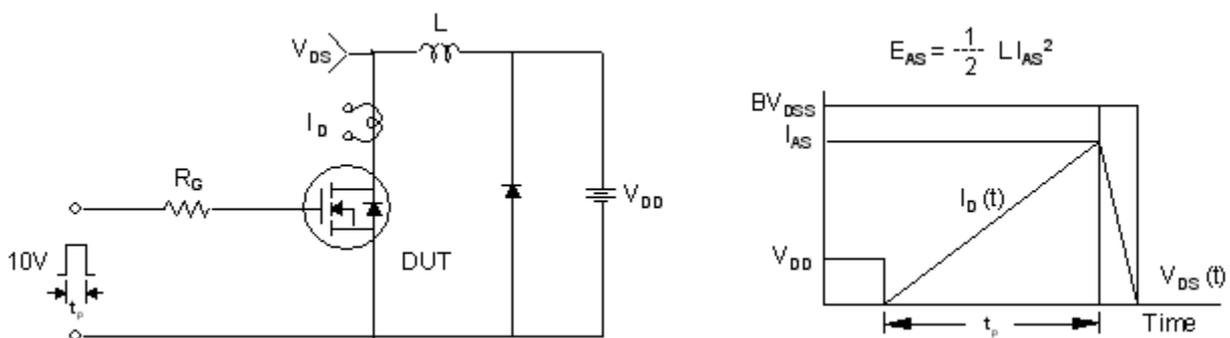


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

Ratings and Characteristic Curves

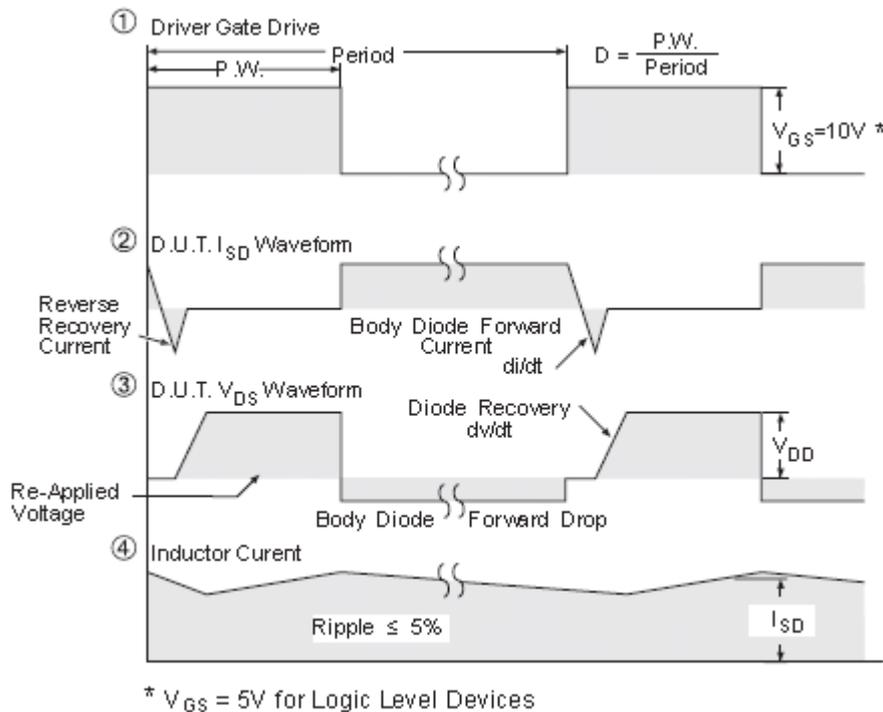
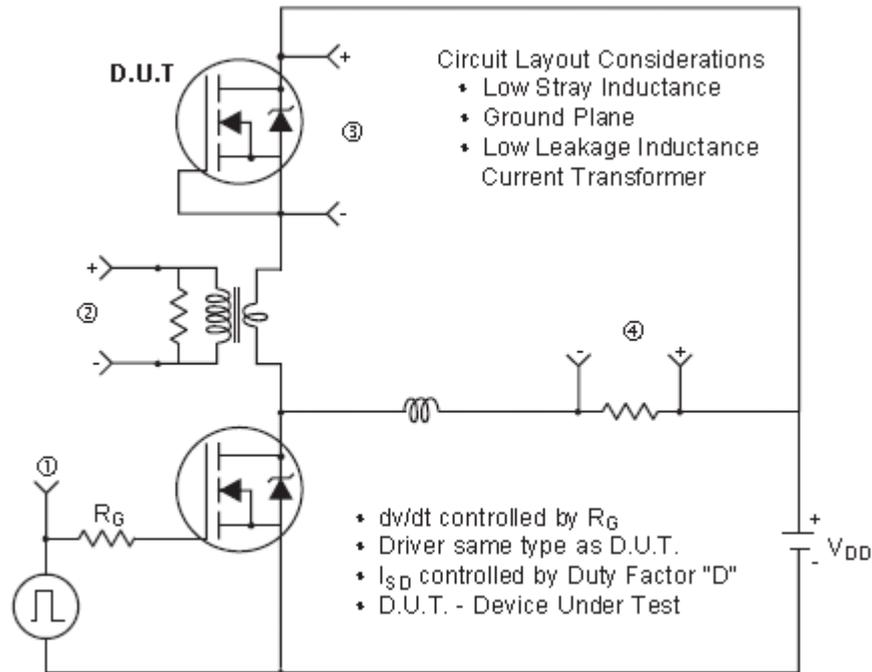
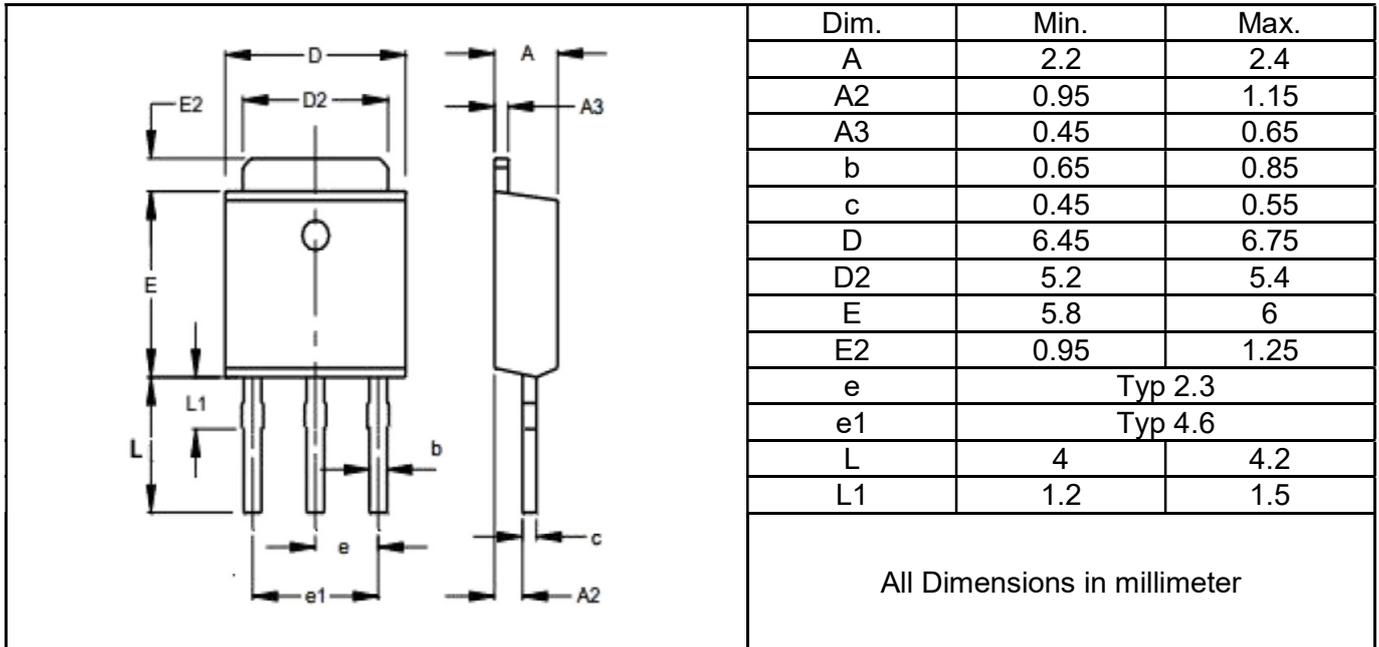


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms (For N-channel)

Package Outline Dimensions Millimeters

TO-251



TO-252

